Constant Stress Load Bias Tests

- Samples Tested:
 - As received 55NiTi (Hot rolled at 900°C)
 - ECAE processed 55NiTi
 - Route 4Bc, 350°C *
 - Route 4Bc, 400°
 - Route 8Bc, 400°C *
- *: Two cycles were run at each stress level. Cooling of 1st cycle and heating of 2nd cycle was graphed.

Equal Channel Angular Extrusion Process at Texas A&M

First Pass (N=1)

Second Pass (N=2)



| | | Billet rotations about | | | | | |
|----------------------|-----------|------------------------|------------|------------|--------------|----------|---------------------------|
| Route | Min. # of | the extrusion axis | | | | Material | Effect on |
| name | passes | 1 → | 2 → | 3 → | 4 → N | Yield* | microstructure |
| А | 1 | 0° | 0° | 0° | etc. | 0.58 | elongation (lamellar) |
| B (B _A) | 2 | +90° | -90° | +90° | etc. | 0.67 | elongation (filamentary) |
| С | 2 | 180° | 180° | 180° | etc. | 0.83 | back/forth shearing |
| C' (B _C) | 4 | +90° | +90° | +90° | etc. | 0.67 | back/forth cross-shearing |
| E | 4 | 180° | 90° | 180° | etc. | 0.78 | back/forth cross-shearing |

* Theoretical yield of fully deformed material after N=4 in billet with length/width ratio of 6

As-Received



ECAE 8Bc at 400°C



100 MPa



200 MPa



300 MPa



Open Loop Strain



Transformation Strain



Work Output



Hysteresis



Grain Size Comparison Old Results



Figure 3. Bright field TEM images recorded above A_f at 175°C showing the grain size reduction due to ECAE processing. Four ECAE passes following (a) route B_c at 400°C b) route B_c at 425°C and (c) route E at 450°C.

NiTiPd₂₅ Characterization Results

As-received material

 $\frac{\text{Nominal compositions}}{\text{Ni}_{25}\text{Ti}_{50}\text{Pd}_{25} \text{ (at. \%)}}$ $\text{Ni}_{22.50}\text{Ti}_{36.71}\text{Pd}_{40.79} \text{ (wt. \%)}$

Processing conditions Extruded at 900°C (7:1 area reduction)

BSE Images – Ext.65



Images taken from etched samples

WDS X-Ray Mapping for Ni – Ext. 65



Short time (5 minute) WDS X-ray map of the etched sample

WDS X-Ray Mapping for Ti – Ext. 65



Short time (5 minute) WDS X-ray map of the etched sample

WDS X-Ray Mapping for Pd – Ext. 65



Short time (5 minute) WDS X-ray map of the etched sample



SEM:BSE (etched sample)

WDS Analyses of Different Regions

| | Pd (at%) | Ti (at%) | Ni (at%) | Total (wt%) |
|---|-------------|-------------|-------------|----------------|
| 1 | 27.17 | 47.17 | 25.66 | 100.21 |
| 2 | 27.19 | 47.81 | 25.01 | 99.69 |
| 3 | 28.65 | 45.94 | 25.41 | 99.54 |
| 4 | 31.29 | 44.02 | 24.69 | 96.67 |
| 5 | 31.83 | 43.96 | 24.21 | 96.90 |
| 6 | 27.77 | 46.90 | 25.34 | 99.90 |
| 7 | 0.29 | 99.29 | 0.42 | 82.10 |
| 8 | 1.25 | 97.88 | 0.87 | 82.61 |

- 1-3: Bright regions
- 4-5: Dark regions
- 6: Matrix
- 7-8: Precipitate

Chemical Analyses (Ext 64)

| Analysis | Ni (at. %) | | Ti (at. %) | | Pd (at. %) | |
|----------|------------|------|------------|------|------------|------|
| No | TAMU | NASA | TAMU | NASA | TAMU | NASA |
| 1 | | 24.9 | | 49.2 | | 25.6 |

NASA GRC results from Inductively Coupled Plasma (ICP) Emission Spectrometry

Chemical Analyses (Ext 65)

| Analysis | Ni (at. %) | | Ti (at. %) | | Pd (at. %) | |
|----------|------------|------|------------|------|------------|------|
| No | TAMU | NASA | TAMU | NASA | TAMU | NASA |
| 1 | 24.4 | 25.3 | 48.0 | 47.8 | 27.7 | 26.7 |
| 2 | 24.7 | 24.9 | 47.9 | 47.9 | 27.4 | 26.4 |
| 3 | 24.7 | | 47.7 | | 27.5 | |
| 4* | 24.8 | | 49.0 | | 26.2 | |
| 5* | 24.6 | | 49.1 | | 26.2 | |
| 6* | 24.7 | | 48.9 | | 26.3 | |

NASA GRC results from Inductively Coupled Plasma (ICP) Emission Spectrometry TAMU results from Wavelength dispersive X-ray Spectrometry (WDS) (Average values)

* Analysis done on **unetched** sample

Chemical Analyses

(Inductively Coupled Plasma (ICP) Emission Spectrometry)

| | Ext. 65 An | alysis 1 | Ext. 65 An | | |
|-------|------------|----------|------------|---------|------|
| Eleme | Measure | Measure | Measure | Measure | Aim |
| nt | d wt.% | d at.% | d wt.% | d at.% | at.% |
| Ni | 22.3 | 25.3 | 22.2 | 24.9 | 25 |
| Pd | 42.9 | 26.7 | 42.7 | 26.4 | 25 |
| Ti | 34.6 | 47.8 | 34.9 | 47.9 | 50 |
| 0 | 0.03065 | 0.13 | 0.0303 | 0.12 | |
| С | ND | | 0.11 | 0.6 | |
| Ν | 0.00185 | 0.009 | 0.0019 | 0.009 | |

| | Ext. 64 An | | |
|---------|------------|--------|------|
| | Measure | Aim | |
| Element | d wt.% | d at.% | at.% |
| Ni | 22.2 | 24.9 | 25 |
| Pd | 41.6 | 25.6 | 25 |
| Ti | 36 | 49.2 | 50 |
| 0 | 0.06525 | 0.26 | |
| С | ND | | |
| Ν | 0.00185 | 0.009 | |

DSC Results (Ext 64 & 65) on as-received and heat treated samples

Heat treatment conditions for Ext 64 and Ext 65

| Batch | Temperature (°C) | Time (hours) |
|-------|-------------------------|--------------|
| | 300 | 1 |
| | 400 | 10 |
| | 500 | 24 |
| | 600 | 24 |
| | 300 | 1 |
| | 400 | 10 |
| | 500 | 24 |
| | 600 | 24 |

Ex65 – DSC Results

DSC Results - Ext 65, As-processed material





Fig. 2. Plots of martensitic transformation temperatures vs. composition for $Ti_{50-x}Pd_{30}Ni_{20+x}$ (x = -0.6-1.5) alloys.

Ex65 - Consolidated DSC data, 1st cycle



Ex65 – 600°C, 24 hour (vacuum) heat treated



Ex64 – DSC Results

DSC Results - Ext 64, As-processed material



Ex64 - Consolidated DSC data, 1st cycle



Ex64 - Consolidated DSC data, 2nd cycle



Ex64 - Comparison of 1st 2nd and 3rd cycle data



